Cloud/Edge/Fog Computing and Blockchain Technologies for Artificial Intelligence of Things

Guest Editor:

Dr. Sergio Trilles Oliver
Institute of New Imaging Technologies (INIT), Universitat Jaume I, Av. Vicente Sos Baynat s/n, 12071 Castelló de la Plana, Spain

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Message from the Guest Editor

IoT and artificial intelligence (AI) should work together harmoniously. The IoT can create the volume of data required to feed ML models. Edge, fog, and cloud are the three layers that make up an IoT architecture.

The Artificial Intelligence of Things (AIoT) may benefit from the use of blockchain in IoT. Blockchain data are securely kept and untouchable because of the great integrity and resilience of the system. When used with ML models, the smart contract concept can provide more security and dependability than the inference stage. Some topics of interest include, but are not limited to:

- IoT applications taking advantage of edge/fog/cloud distributed computing;
- Distributed architectures in support of IoT applications;
- Trust data collection and computing for distributed IoT using AIoT;
- Machine learning and data science in/for edge–fog–cloud IoT;
- Edge/fog-computing-based algorithms/method design for edge–blockchain systems;
- The role of blockchain in the convergence of AI, IoT, and edge–cloud;
- Implementation/testbed/deployment of edge/fog/cloud computing, AIoT and blockchain.

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Special Issue

Editor-in-Chief

Prof. Dr. Flavio Canavero
Department of Electronics and Telecommunications,
Politecnico di Torino, 10129 Torino, Italy

Message from the Editor-in-Chief

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